	Search Terms
1	ADDRESS
2	ADDRESSED
3	ADDRESSEDS
4	ADDRESSES
5	ADDRESSING
6	ADDRESSINGS
7	ANOMALIES
8	ANOMALY
9	ANOMALYS
10	CLOCK
11	CLOCKS
12	POSITION
13	POSITIONED
14	POSITIONEDS
15	POSITIONING
16	POSITIONINGS
17	POSITIONS
18	PULSE
19	PULSE-WIDTH
20	PULSE-WIDTHS
21	PULSES
22	PULSEWIDTH
23	PULSEWIDTHS
24	RECOVERED
25	RECOVEREDS
26	RECOVERIES
27	RECOVERING
28	RECOVERINGS
29	RECOVERY
30	RECOVERYS
31	SCREEN
32	SCREENS
33	START

	Total	US-PGPUB	USPAT	USOCR	EPO	JPO	Derwent	IBM TDB
1	669739							
2	196010							
3	0							
4	285365							
5	116293							
6	137							
7	19092							
8	14362							
9	5							
10	567110							
11	80302							
12	6003177							
13	2746957							
14	5							
15	1141897							
16	2676							
17	2051558							
18	965402							
19	15227							
20	291							
21	529594							
22	2791							
23	537							
24	469312							
25	1							
26	8894							
27	265691							
28	8							
29	487304							
30	7							
31	970971							
32	168884							
33	1155656							

	Search Terms
34	STARTED
35	STARTEDS
36	STARTING
37	STARTINGS
38	STARTS
39	WAVEFORM
40	WAVEFORMS
41	WIDTH
42	WIDTHS
43	(((((ANOMALY OR WAVEFORM) SAME ((PULSEWIDTH OR PULSE-WIDTH) OR (WIDTH SAME PULSE) OR PULSE)) AND ((RECOVERING OR RECOVERED OR RECOVERY) SAME CLOCK)) AND (SCREEN SAME (POSITIONING OR POSITIONED OR POSITION))) AND (((STARTED OR STARTING OR START) SAME (ADDRESSING OR ADDRESSED OR ADDRESS) SAME PULSE) SAME ((PULSEWIDTH OR PULSE-WIDTH) OR (WIDTH SAME PULSE) OR PULSE)))

	Total	US-PGPUB	USPAT	USOCR	EPO	JPO	Derwent	IBM TDB
34	550978							
35	2							
36	1314466							
37	243							
38	527332							
39	271564							
40	125269							
41	1952843							
42	215701							
43	7							

	U	1	Document ID	Issue Date	Pages	Title	Current OR
1	X		US 20040102910 A1	20040527	9	Methods for displaying jitter and other anomalies in long acquisition data records	702/67
2	X		US 6578093 B1	20030610		System for loading a saved write pointer into a read pointer of a storage at desired synchronization points within a horizontal video line for synchronizing data	710/52
3	X		US 6285762 B1	20010904		Optical disk, optical disk barcode forming method, optical disk reproduction apparatus, marking forming apparatus, method of forming a laser marking on an optical disk, and a method of manufacturing an optical disk	380/203
4	X		US 5341470 A	19940823		Computer graphics systems, palette devices and methods for shift clock pulse insertion during blanking	345/545
5	X		US 4614971 A	19860930	12	Error eliminating system for teletext	348/466
6	X		US 20040102910 A	20040527		Periodic waveform anomaly e.g. jitter determining method for digital system, involves setting pulse start address and initial screen position, and displaying pulse in time-aligned position	
7	X		US 3493938 A	19700203		RECIRCULATING DELAY LINE SIGNAL STORAGE SYSTEM	365/77

	Current XRef	Retrieval Classif	Inventor	S	C	P	2	3	4	5	Image Doc. Displayed	PT
1			Letts, Peter J.								US 20040102910	
2	345/547; 345/558; 365/189.05		Armen; Stephen F. et al.									
3	380/201; 705/51; 705/57; 713/193		Gotoh; Yoshiho et al.									
4	345/559; 345/593		Simpson; Richard D. et al.									
5	348/468; 348/478; 348/607		Maney; George A. et al.								US 4614971	
6			LETTS, P J									
7	333/165		CUCCIO ALLEN B J									

	Search Terms
1	LETTS-PETER-J
2	LETTS-PETER-JES
3	LETTS-PETER-J.IN.

	Total	US-PGPUB	USPAT	USOCR	EPO	JPO	Derwent	IBM TDB
1	12							
2	0							
3	12							

	U	1	Document ID	Issue Date	Pages	Title	Current OR
1	X		US 20040102910 A1	20040527	9	Methods for displaying jitter and other anomalies in long acquisition data records	702/67
2	X		US 20020180737 A1	20021205		Method and apparatus for computing thresholds for identification of waveform anomalies	345/440.1
3	X		US 6778931 B1	20040817		Test and measurement instrument having multi-channel telecommunications mask testing capability	702/117
4	X		US 6728648 B1	20040427		Test and measurement instrument having telecommunications mask testing capability with an autofit to mask feature	702/71
5	X		US 6642926 B1	20031104	8	Test and measurement instrument having telecommunications mask testing capability with a mask zoom feature	345/440.1
6	X		US 6297796 B1	20011002		Ink saver apparatus and method for use in a test and measurement instrument	345/440.1
7	X		JP 2001116770 A	20010427		MEASURING INSTRUMENT AND MASK TEST METHOD	
8	X		JP 2001099870 A	20010413		MEASURING APPARATUS AND CONTROL METHOD THEREOF	
9	X		JP 2001099869 A	20010413		MEASURING APPARATUS AND MEASURING METHOD	
10	X		EP 1094321 A2	20010425		A test and measurement instrument having telecommunications mask testing capability with a mask zoom feature	

	Current XRef	Retrieval Classif	Inventor	S	C	P	2	3	4	5	Image Doc. Displayed	PT
1			Letts, Peter J.								US 20040102910	
2			Letts, Peter J.									
3	345/690		Letts; Peter J. et al.									
4	702/57; 702/66; 702/67; 702/69; 702/73		Letts; Peter J.									
5	345/474; 345/538; 345/543; 345/556; 345/563; 345/94; 702/57; 702/66; 702/67; 702/71; 702/73; 702/80		Letts; Peter J.								US 6642926	
6			Letts; Peter J. et al.									
7			LETTS, PETER J et al.									
8			LETTS, PETER J									
9			LETTS, PETER J									
10			LETTS, PETER J									

	U	1	Document ID	Issue Date	Pages	Title	Current OR
11	X		EP 1094320 A2	20010425		A test and measurement instrument having multi-channel telecommunications mask testing capability	
12	X		EP 1089079 A2	20010404		A test and measurement instrument having telecommunications mask testing capability with an autofit to mask feature	

	Current XRef	Retrieval Classif	Inventor	S	C	P	2	3	4	5	Image Doc. Displayed	PT
11			LETTS, PETER J et al.									
12			LETTS, PETER J									

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3) Limit the results by selecting Search Options.
4) Click Search. See Search Examples

```
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ph>address)<and>
(pulse<paragraph>width)<and>
(screen<or>display)
```

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